

**Search Notes**

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Applicant(s)/Patent under  
Reexamination

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Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
360	235.4	9/12/2006	TJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east Report	9/12/2006	TJ